

<b>Notice of References Cited</b>	Application/Control No. 10/568,706		Applicant(s)/Patent Under Reexamination OHMI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0230986	12-2003	Horsky et al.	315/111.81
*	B	US-2002/0058107	05-2002	Fareed et al.	427/255.39
*	C	US-2003/0098419	05-2003	Ji et al.	250/373
	D	US-			
	E	US-			
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	J	US-			
	K	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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